

<b>Notice of References Cited</b>	Application/Control No. 10/750,580	Applicant(s)/Patent Under Reexamination HIGASHI ET AL.	
	Examiner Thinh T. Nguyen	Art Unit 2818	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,252,229	06-2001	Hays et al.	250/338.4
*	B	US-6,686,653	02-2004	Jerominek et al.	257/680
*	C	US-2002/0135869	09-2002	Banish et al.	359/350
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	K	US-			
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	M	US-			

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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